Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/609,477	ENDO ET AL.	
Examiner	Art Unit	
TAN X. DINH	2627	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			
Interference Search History Printout		3/21/2007	T.D

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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